

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10601015	AIK, ERIC TEH GIM
	Examiner Rossoshek, Helen	Art Unit 2825

Notes	Date	Examiner
EAST (USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB)	8/1/2005	HR
IEEE	8/1/2005	HR
PD	4/20/2006	HR

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Class	Sub Class	Date	Examiner
716	3-5,10,11,14,17,18	8/1/2005	HR
714	725	8/1/2005	HR
702	117	8/1/2005	HR
UPDATED	UPDATED	4/24/2006	HR

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